# 20 V, 1.0 A, Low V<sub>CE(sat)</sub> NPN Transistor

ON Semiconductor's e²PowerEdge family of low  $V_{CE(sat)}$  transistors are miniature surface mount devices featuring ultra low saturation voltage ( $V_{CE(sat)}$ ) and high current gain capability. These are designed for use in low voltage, high speed switching applications where affordable efficient energy control is important.

Typical applications are DC-DC converters and power management in portable and battery powered products such as cellular and cordless phones, PDAs, computers, printers, digital cameras and MP3 players. Other applications are low voltage motor controls in mass storage products such as disc drives and tape drives. In the automotive industry they can be used in air bag deployment and in the instrument cluster. The high current gain allows e<sup>2</sup>PowerEdge devices to be driven directly from PMU's control outputs, and the Linear Gain (Beta) makes them ideal components in analog amplifiers.

#### **Features**

- AEC-Q101 Qualified and PPAP Capable
- S Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements
- These are Pb-Free Devices\*



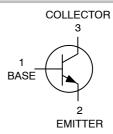
# ON Semiconductor®

http://onsemi.com

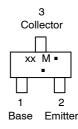
# 20 VOLTS, 1.0 AMPS NPN LOW V<sub>CE(sat)</sub> TRANSISTOR



SC-89 CASE 463C STYLE 1



#### **MARKING DIAGRAM**



xx = Specific Device Code

M = Date Code\*
■ = Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation may vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NSS20101JT1G	SC-89 (Pb-Free)	3,000 / Tape & Reel
SNSS20101JT1G	SC-89 (Pb-Free)	3,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# **MAXIMUM RATINGS** $(T_A = 25^{\circ}C)$

Rating	Symbol	Max	Unit
Collector-Emitter Voltage	V <sub>CEO</sub>	20	Vdc
Collector-Base Voltage	V <sub>CBO</sub>	40	Vdc
Emitter-Base Voltage	V <sub>EBO</sub>	6.0	Vdc
Collector Current – Continuous	I <sub>C</sub>	1.0	Α
Collector Current - Peak	I <sub>CM</sub>	2.0	Α
Electrostatic Discharge	ESD	HBM Class 3B MM Class C	

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation  T <sub>A</sub> = 25°C  Derate above 25°C	P <sub>D</sub> (Note 1)	255 2.0	mW mW/°C
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub> (Note 1)	490	°C/W
Total Device Dissipation  T <sub>A</sub> = 25°C  Derate above 25°C	P <sub>D</sub> (Note 2)	300 2.4	mW mW/°C
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub> (Note 2)	415	°C/W
Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. FR-4 @ 100 mm², 1 oz. copper traces.

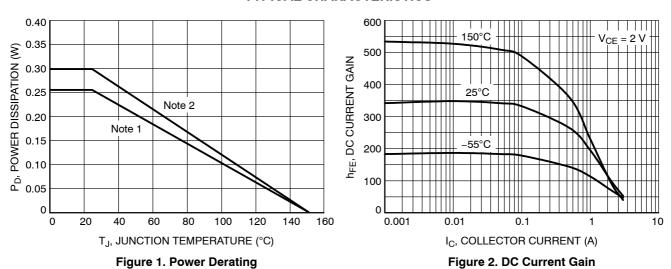
2. FR-4 @ 500 mm², 1 oz. copper traces.

# **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Collector – Emitter Breakdown Voltage (I <sub>C</sub> = 10 mAdc, I <sub>B</sub> = 0)	V <sub>(BR)CEO</sub>	20			Vdc
Collector – Base Breakdown Voltage (I <sub>C</sub> = 0.1 mAdc, I <sub>E</sub> = 0)	V <sub>(BR)CBO</sub>	40			Vdc
Emitter – Base Breakdown Voltage ( $I_E = 0.1 \text{ mAdc}, I_C = 0$ )	V <sub>(BR)EBO</sub>	6.0			Vdc
Collector Cutoff Current (V <sub>CB</sub> = 30 Vdc, I <sub>E</sub> = 0)	I <sub>CBO</sub>			0.1	μAdc
Emitter Cutoff Current (V <sub>EB</sub> = 5.0 Vdc)	I <sub>EBO</sub>			0.1	μAdc
ON CHARACTERISTICS					
DC Current Gain (Note 3) ( $I_C = 10 \text{ mA}, V_{CE} = 2.0 \text{ V}$ ) ( $I_C = 100 \text{ mA}, V_{CE} = 2.0 \text{ V}$ ) ( $I_C = 500 \text{ mA}, V_{CE} = 2.0 \text{ V}$ ) ( $I_C = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$ )	h <sub>FE</sub>	200 200 150 100		500	
Collector – Emitter Saturation Voltage (Note 3) ( $I_C = 10 \text{ mA}$ , $I_B = 0.5 \text{ mA}$ ) ( $I_C = 0.10 \text{ A}$ , $I_B = 0.010 \text{ A}$ ) ( $I_C = 0.5 \text{ A}$ , $I_B = 0.050 \text{ A}$ ) ( $I_C = 1.0 \text{ A}$ , $I_B = 0.1 \text{ A}$ )	V <sub>CE(sat)</sub>			0.015 0.040 0.115 0.220	V
Base – Emitter Saturation Voltage (Note 3) $(I_C = 0.5 \text{ A}, I_B = 50 \text{ mA})$	V <sub>BE(sat)</sub>			1.1	V
Base – Emitter Turn–on Voltage (Note 3) (I <sub>C</sub> = 0.5 A, V <sub>CE</sub> = 2.0 V)	V <sub>BE(on)</sub>			0.90	V
Cutoff Frequency (I <sub>C</sub> = 100 mA, V <sub>CE</sub> = 2.0 V, f = 100 MHz)	f <sub>T</sub>		350		MHz
Input Capacitance (V <sub>EB</sub> = 0.5 V, f = 1.0 MHz)	Cibo		40		pF
Output Capacitance (V <sub>CB</sub> = 4.0 V, f = 1.0 MHz)	Cobo		6		pF

<sup>3.</sup> Pulsed Condition: Pulse Width = 300 msec, Duty Cycle  $\leq$  2%.

# **TYPICAL CHARACTERISTICS**



## TYPICAL CHARACTERISTICS

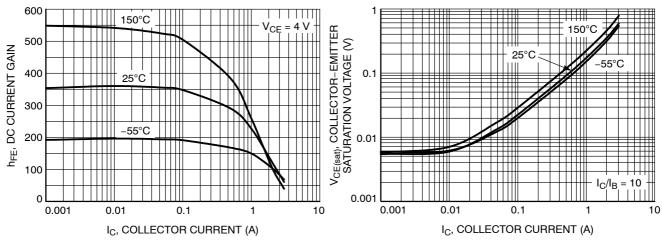


Figure 3. DC Current Gain

Figure 4. Collector-Emitter Saturation Voltage

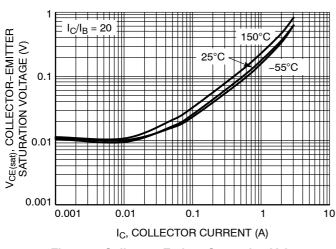


Figure 5. Collector-Emitter Saturation Voltage

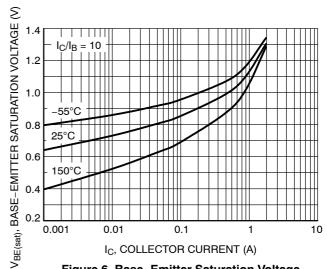


Figure 6. Base-Emitter Saturation Voltage

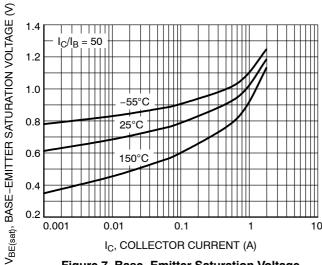


Figure 7. Base-Emitter Saturation Voltage

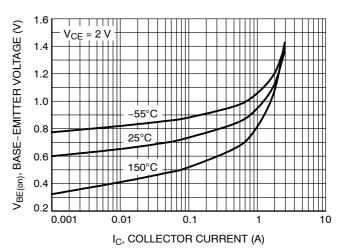
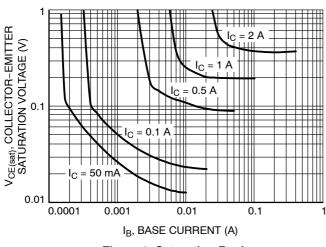


Figure 8. Base-Emitter Voltage

## **TYPICAL CHARACTERISTICS**

60

50

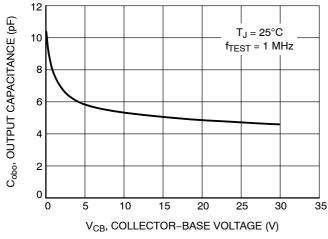


Gibo, INPUT CAPACITANCE (pF)  $f_{TEST} = 1 \text{ MHz}$ 40 30 20 10 0

 $T_J = 25^{\circ}C$ 

Figure 9. Saturation Region

V<sub>EB</sub>, BASE EMITTER VOLTAGE (V) Figure 10. Input Capacitance



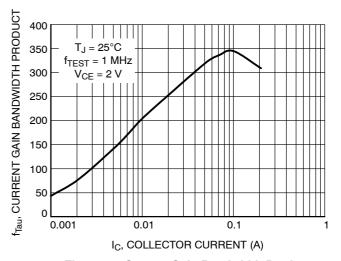


Figure 11. Output Capacitance

Figure 12. Current Gain Bandwidth Product

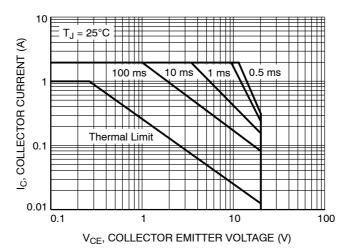
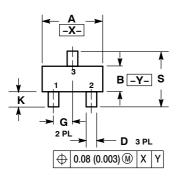
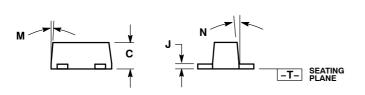


Figure 13. Safe Operating Area

## PACKAGE DIMENSIONS

SC-89. 3 LEAD CASE 463C-03 **ISSUE C** 





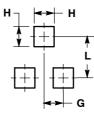
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 1 (4.30M, 1962.)
  2 CONTROLLING DIMENSION: MILLIMETERS
  3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
  4. 463C-01 OBSOLETE, NEW STANDARD 463C-02.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.50	1.60	1.70	0.059	0.063	0.067	
В	0.75	0.85	0.95	0.030	0.034	0.040	
С	0.60	0.70	0.80	0.024	0.028	0.031	
D	0.23	0.28	0.33	0.009	0.011	0.013	
G	0.50 BSC			0.020 BSC			
Н	0.53 REF			0.021 REF			
J	0.10	0.15	0.20	0.004	0.006	0.008	
K	0.30	0.40	0.50	0.012	0.016	0.020	
L	1.10 REF			0	.043 RE	F	
M			10			10	
N			10 -			10	
S	1.50	1.60	1.70	0.059	0.063	0.067	

STYLE 1: PIN 1. BASE 2. EMITTER 3. COLLECTOR

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and 👊 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice on semiconductor and war engineer trademarks of semiconductor components industries, Ite (SciLLC) solitate services are injective to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada

Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

NSS20101J/D